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<td>Author(s)</td>
<td>Kumazaki, Yusuke; Watanabe, Akio; Yatabe, Zenji; Sato, Taketomo</td>
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<tr>
<td>Citation</td>
<td>Journal of the Electrochemical Society, 161(10): H705-H709</td>
</tr>
<tr>
<td>Issue Date</td>
<td>2014-08-06</td>
</tr>
<tr>
<td>Doc URL</td>
<td><a href="http://hdl.handle.net/2115/56975">http://hdl.handle.net/2115/56975</a></td>
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<tr>
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**Abstract**

The correlation between structural and photoelectrochemical properties of GaN porous nanostructures formed by photo-assisted electrochemical etching is investigated. The effects of etching parameters on the structural properties, such as porosity and pore size, are discussed. The photoelectrochemical properties, including photovoltaic performance and photocatalytic activity, are measured and correlated with the structural properties. The results indicate that the etching conditions can significantly influence the performance of these nanostructures in photovoltaic and photocatalytic applications.

**Keywords**


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**Journal Reference**

Correlation between Structural and Photoelectrochemical Properties of GaN Porous Nanostructures Formed by Photo-Assisted Electrochemical Etching

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We investigated the correlation between structural and photoelectrochemical properties of GaN porous nanostructures formed by photo-assisted electrochemical etching. The porous nanostructures were formed during light irradiation of the top-surface of homo-epitaxial layers grown on freestanding GaN substrates. The pore depth, wall thickness, and surface morphology of porous nanostructures were strongly influenced by the way holes were generated by the light irradiation were supplied. Such structural features influenced the optical properties of GaN porous nanostructures. The photoluminescence peaks measured on GaN porous nanostructures were shifted to higher energies because of the quantum confinement in the thin GaN walls between pores. Formation of porous nanostructure decreased the photoelectroluminescence of the GaN surface, and the smallest reflectance was obtained from the porous sample having large pores on its surface after the ultrathin layer with small pores had been removed by surface-etching. The photoelectrochemical response measured on GaN porous nanostructures in a NaCl electrolyte were drastically enhanced by the unique features of those structures, such as low photoelectroluminescence and large surface area. The largest photocurrents were obtained from the sample from which H2PO4 treatment had removed the ultrathin layer without thinning the pore walls.

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Manuscript submitted June 6, 2014; revised manuscript received July 24, 2014. Published August 6, 2014. This was Paper 51 presented at the San Francisco, California, Meeting of the Society, October 27-November 1, 2013.

Experimental

As shown schematically in Fig. 1a, n-type GaN epitaxial layers \( (N_D = 2 \times 10^{16} \text{ cm}^{-3}) \) grown on freestanding GaN substrates \( (N_D > 1 \times 10^{18} \text{ cm}^{-3}) \) were used for the electrochemical formation of GaN porous nanostructures. The threading dislocation density (TDD) of GaN substrates is approximately \( 2.2 \times 10^5 \text{ cm}^{-2} \), which is two or three orders of magnitude less than that of hetero-epitaxial layers grown on sapphire substrates. \( \) The electrochemical current was supplied through the Au-ohmic contact on the back side of the substrate, and the electrochemical process was performed using a standard cell with three electrodes: an n-type GaN working electrode, a Pt counter electrode, and a Ag/AgCl reference electrode (see Fig. 1b). We used a mixture of 1 mol/L H2SO4 and 1 mol/L H3PO4 (pH = 2.5) as an electrolyte to remove resulting oxides and expose the raw GaN surface for further etching. We also used the ultrathin layer with small pores removed by surface-etching to form GaN porous nanostructures. The smallest reflectance was obtained from the sample from which H2PO4 treatment had removed the ultrathin layer without thinning the pore walls.

Typical cyclic voltammograms of an n-GaN epitaxial layer that were obtained at light intensities \( P_D \) between 0 and 40 mW/cm2 by

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Results and Discussion

Figures 3 show the top and cross-sectional SEM images of GaN porous samples formed at $V_a = 1.0 \text{ V}$, $P_{\text{IN}} = 5.0 \text{ mW/cm}^2$, and various anodization times $t_a$: (a) $t_a = 300 \text{ s}$ (sample A), (b) $t_a = 600 \text{ s}$ (sample B), (c) $t_a = 1800 \text{ s}$ (sample C), and (d) $t_a = 600 \text{ s}$ with a chemical treatment (the process used to form sample B' will be described later). The pore density formed on the surface was estimated from SEM images to be about $10^{10} \text{ cm}^{-2}$, which is much higher than the dislocation density of the substrates. This suggests that the pore formation in this study was substantially unaffected by the dislocations in GaN substrates. In the cross-sectional views of samples A and B, we can clearly see pores over 30 nm in diameter, and in the top views we can see pores with diameters under 10 nm. These results suggest that an ultrathin porous layer having smaller-diameter pores formed on top of a thick porous layer having larger-diameter pores. Figure 4 shows the relationship between pore depth $d_p$ and the charge density $Q$ passing through the working electrode during the anodization. The $d_p$ increased with $Q$, and the slope of the experimental curve decreased gradually. This gradual decrease indicates that the rate of pore formation in the depth direction decreased with increasing $Q$. Considering the proportional relationship between the amount of electrochemical reaction and $Q$, as described by Faraday’s law, the decreased slope shown in Fig. 4 indicates that lateral etching of pore walls occurred in addition to the vertical etching in the depth direction.

As shown in Fig. 3c, on the other hand, the structural features of sample C, formed at $t_a = 1800 \text{ s}$, differ from those of samples A and B. In the top view, we can clearly see pores over 30 nm in diameter, and in the cross-sectional view, we can see no ultrathin porous layer with smaller pores. Furthermore, as shown in Fig. 4, the $d_p$ in sample C was smaller than that in samples formed at shorter $t_a$ and smaller $Q$. These results indicate that surface etching as well as vertical etching in the depth direction occurred.

We considered the mechanism of GaN porous nanostructure formation by referring to the “Beale model” proposed for porous Si...
nanostructures. Figure 5 shows the formation flow for GaN porous nanostructures schematically. At the initial stage, photo-generated holes transferred preferentially to the pore tips at which electric field lines concentrated, leading to the formation of porous nanostructures ((a) → (b)). Since the holes generated near the surface also transferred to the pore walls, etching of pore walls and the top-surface occurred in addition to the vertical etching at the pore tips ((b) → (c)). After reaching a critical depth, etching proceeded preferentially at the top-surface removing the ultrathin porous layer with smaller size pore ((c) → (d)), resulting in larger pores observed in sample C. There are two possible reasons for this phenomenon. One is due to the reduced diffusion of ions to pore tips in deeper pores, and another is due to the decreased hole-supply to pore tips. A similar preferential top-surface etching is also observed on InP porous nanostructures under irradiation. This formation model can compatibly explain both the SEM results in Figs. 3a–3c and the correlation between pore depth and Q shown in Fig. 4.

The correlation with the crystal quality such as a dislocation density has been frequently reported in the chemical and electrochemical etching. A previous study found that photo-assisted electrochemical etching of GaN layers occurred only at dislocation-free areas because the dislocations acted as recombination centers for the photogenerated carries. Another study found that the etching using a HF solution proceeds thorough the dislocations and grain boundaries, whereas the etching using a KOH solution takes place at crystal grains. These reports showed that the etching profile was strongly affected by the dislocation density and distribution in GaN layers. However, that was not the case with this study. The TDD of the GaN epitaxial layer used in this study is $2.2 \times 10^{6}$ cm$^{-2}$, which means approximately 1 dislocation in 5 $\mu$m$^2$. The pore density of the present GaN porous nanostructures, however, is estimated to be over 5000 pores per 5 $\mu$m$^2$. This fact indicates that the formation model proposed here is acceptable for the present study free of influence from the dislocations in GaN layers.

The correlation between the structural properties and optical properties was investigated in the photoluminescence and photoreflectance measurements conducted on the GaN porous samples shown in Figs. 3a–3d. As for sample B’ shown in Fig. 3d, the ultrathin porous layer with smaller pores was removed by immersing the sample in a heated H$_3$PO$_4$ solution for 1 min after the formation of porous nanostructure with $t_a = 600$ sec. Figure 6a shows PL spectra obtained at room temperature from a non-porous sample and porous sample C formed at $t_a = 1800$ s, and (b) PL peak positions of porous samples and a non-porous sample.

![Figure 4](image1.png)  
**Figure 4.** Pore depth as a function of charge density $Q$.

![Figure 5](image2.png)  
**Figure 5.** Model of GaN porous nanostructure formation by photo-assisted electrochemical etching.

![Figure 6](image3.png)  
**Figure 6.** (a) PL spectra obtained at room temperature from a non-porous sample and porous sample C formed at $t_a = 1800$ s, and (b) PL peak positions of porous samples and a non-porous sample.
emission around 3.4 eV with a full width at half maximum (FWHM) of ~50 meV. In the present samples, two additional peaks related to longitudinal optical (LO) phonon replicas were also observed. The position of main peak obtained from sample C is at 3.404 eV which is about 5 meV higher than that of the main peak obtained from the non-porous sample. We believe that the observed blueshift is most likely caused when the thickness of pore walls was about 21 nm.

This estimated thickness is very consistent with the thickness measured in SEM observation. The positions of the main peaks obtained from all porous samples are summarized in Fig. 6b. The peak position of sample A formed at $t_a = 300$ s, sample B formed at $t_a = 600$ s, sample C formed at $t_a = 1800$ s, and sample $B'$ formed at $t_a = 600$ s after $H_3PO_4$ treatment.

Figure 7 shows diffuse reflectance spectra of porous samples and a non-porous sample. The porous samples could be separated into two groups according to reflectance value: a higher-$R$ group comprising samples like A and B, and a lower-$R$ group comprising samples like C and $B'$. SEM observation of the porous samples shown in Figs. 3a–3d revealed that the photoreflectance depends more on surface morphology than pore depth. Comparing sample $B'$ with sample B, one sees the reflectance surface etching using a chemical treatment decreased reflectance even though the electrochemical conditions forming porous nanostructure were the same for both samples. This phenomenon is very similar to the case of InP porous nanostructures. In samples C and $B'$, pores with enlarged openings appeared on the surface, where air holes are closely aligned between the thin GaN walls. This kind of air-dielectric composite has a refractive index close to unity, leading to low reflectance at the air interface.

Photoreflectance characteristics of various GaN porous nanostructures were measured in 1 mol/L NaCl electrolyte under irradiation with monochromatic light ($\lambda = 350$ nm, $P_{IN} = 0.1$ mW/cm$^2$). Figure 8 compares the photocurrent-voltage curves obtained on porous samples and the non-porous sample. No current degradation or structural change was observed in repeated experiments because oxidation of the GaN surface was suppressed oxidation in the Cl$^-$-containing electrolyte. Here, the dominant electrochemical reactions in this system are thought here to be due to the photo-assisted electrolysis of water, the reduction of H$^+$, and the oxidation of Cl$^-$. As shown in Fig. 8, the photocurrents of all porous samples increased much more than did the photo-current of the non-porous sample. External quantum efficiency $\eta$ can be calculated by

$$\eta = \frac{hc}{q \lambda P_{IN}} \left| J_{ph} - J_{dark} \right|,$$

where $h$ is Planck’s constant, $c$ is speed of light, $q$ is elementary charge, $J_{ph}$ and $J_{dark}$ are current density under irradiation and dark condition, respectively. From the calculations using Eq. 2, it was found that $\eta$ of the non-porous sample was very low, i.e., only 0.001% at 0 V and 0.332% at 1.0 V applied bias. After the formation of porous structures, however, $\eta$ were drastically enhanced to as high as 2.926% at 0 V. This might be due to the unique features of porous nanostructures, such as their large surface area and low reflectance. These results enable us to conclude that the formation of porous nanostructures is effective for improving photoelectrochemical characteristics and is a promising technique for use in photoelectrochemical water splitting.

It was also found that the photoelectrochemical characteristics were greatly influenced by the structural variations of porous samples. Structural and optical properties of porous samples are listed in Table I. Photocurrents of sample B were larger than those of sample A. Since the most apparent difference between sample A and B was pore depth shift Photoreflectance density

<table>
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<tr>
<th>Sample</th>
<th>Pore depth $d_p$ (nm)</th>
<th>PL peak shift ($\Delta E$) (meV)</th>
<th>Photoreflectance $R$ (%)</th>
<th>Photocurrent density $J_{ph}$ ($\mu$A/cm$^2$)</th>
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<tr>
<td>A</td>
<td>200</td>
<td>0</td>
<td>9.6</td>
<td>55.3</td>
</tr>
<tr>
<td>B</td>
<td>340</td>
<td>3.0</td>
<td>9.4</td>
<td>77.7</td>
</tr>
<tr>
<td>C</td>
<td>350</td>
<td>5.0</td>
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<tr>
<td>B'</td>
<td>340</td>
<td>3.0</td>
<td>3.5</td>
<td>82.7</td>
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depth, it would appear that the improved photoelectrochemical characteristics of sample B were due to its increased pore depth increasing the pores’ contribution to the sample’s surface area. On the other hand, the photocurrents of sample C were lower than those of sample B in spite of the pore depths of the two samples being almost the same. One possible reason for this is the thinning of the pore walls in sample C. As described above, the thickness of pore wall decreased during the prolonged process with \( t_a = 1800 \) s. The thinning of the pore walls probably decreased thickness of photoabsorption region in the pore walls, and/or degraded carrier transport properties by increasing resistivity.

The photocurrent of sample B which is the highest among porous samples A–C was furthermore improved by \( \text{H}_3\text{PO}_4 \) treatment as observed at sample B’. SEM observation and photoreflectance measurements revealed that its lower reflectance after the removal of ultrathin porous layer was obtained without thinning the pore walls. The typical relationship between photoreflectance \( \rho \) and photocurrent \( J_{\text{ph}} \) is expressed by

\[
J_{\text{ph}} \propto \phi_{\text{ph}} (100 - \rho),
\]

where \( \phi_{\text{ph}} \) is the irradiated photon flux. Assuming that the material properties of sample B and B’ are the same, we have the following equation:

\[
\frac{J_{\text{phB'}}}{J_{\text{phB}}} = \frac{100 - \rho_{B'}}{100 - \rho_B}.
\]

Substituting the values obtained in this study to Eq. 4, we obtained almost equal values of 1.06 and 1.07, respectively, for the left hand side and right hand side of the equation. Accordingly, the increase of photocurrent by \( \text{H}_3\text{PO}_4 \) treatment could be explained by the effect of the decrease of photoreflectance in Eq. 4. In such a situation, the number of photons absorbed at pore walls increased, resulting in the improvement of photoelectrochemical conversion efficiency. These results indicate that the control of porous nanostructures features such as surface morphology, thickness of pore walls, and pore depth is crucial to the improvement of the photoelectrochemical characteristics of GaN porous nanostructures.

Conclusions

Porous nanostructures were formed on n-GaN homo-epitaxial layers using photo-assisted electrochemical etching. From SEM observations, it was found that the way holes were generated by the light irradiation played a key role in determining the pore depth, wall thickness, and surface morphology of GaN porous nanostructures. Under light irradiation of the top-surface, the pore diameter increased with the anodization time \( t_a \) because of the preferential etching of pore walls on the top surface. PL measurements revealed that the wall thickness decreased with increasing \( t_a \), which is very consistent with the results of SEM observation. Formation of porous nanostructure decreased the photoreflectance of the GaN surface, and the smallest reflectance was obtained from the porous sample having large pores on the surface after the ultrathin layer with small pores had been removed by surface-etching. The photoelectrochemical responses measured on GaN porous nanostructures in a NaCl electrolyte were drastically enhanced by the unique features of those structures, such as low photoreflectance and large surface area. From the comparison of various porous samples it was found that the largest photocurrents were obtained on the sample from which \( \text{H}_3\text{PO}_4 \) treatment had removed the ultrathin layer without thinning the pore walls. These results indicate that GaN porous nanostructures formed by the photo-assisted electrochemical etching are very promising for use as the photoelectrochemical electrodes expected to play a role in the next-generation green technologies.

Acknowledgments

This work was supported in part by a grant-in-Aid for Scientific Research (B) – 25289079 from Japan Society for the Promotion of Science (JSPS).

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